

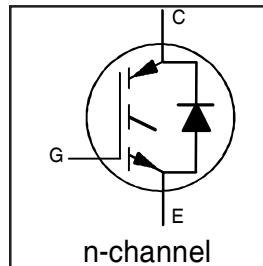
# IRG4PC30FDPbF

## INSULATED GATE BIPOLEAR TRANSISTOR WITH ULTRAFAST SOFT RECOVERY DIODE

Fast CoPack IGBT

### Features

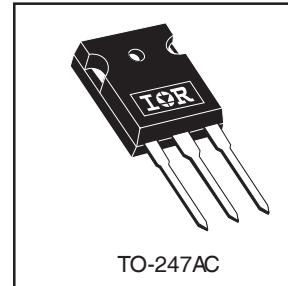
- Fast: Optimized for medium operating frequencies ( 1-5 kHz in hard switching, >20 kHz in resonant mode).
- Generation 4 IGBT design provides tighter parameter distribution and higher efficiency than Generation 3
- IGBT co-packaged with HEXFRED™ ultrafast, ultra-soft-recovery anti-parallel diodes for use in bridge configurations
- Industry standard TO-247AC package
- Lead-Free



$V_{CES} = 600V$
$V_{CE(on)} \text{ typ.} = 1.59V$
$@V_{GE} = 15V, I_C = 17A$

### Benefits

- Generation -4 IGBT's offer highest efficiencies available
- IGBT's optimized for specific application conditions
- HEXFRED diodes optimized for performance with IGBT's . Minimized recovery characteristics require less/no snubbing
- Designed to be a "drop-in" replacement for equivalent industry-standard Generation 3 IR IGBT's



### Absolute Maximum Ratings

	Parameter	Max.	Units
$V_{CES}$	Collector-to-Emitter Voltage	600	V
$I_C @ T_C = 25^\circ\text{C}$	Continuous Collector Current	31	A
$I_C @ T_C = 100^\circ\text{C}$	Continuous Collector Current	17	
$I_{CM}$	Pulsed Collector Current ①	120	
$I_{LM}$	Clamped Inductive Load Current ②	120	
$I_F @ T_C = 100^\circ\text{C}$	Diode Continuous Forward Current	12	
$I_{FM}$	Diode Maximum Forward Current	120	W
$V_{GE}$	Gate-to-Emitter Voltage	$\pm 20$	
$P_D @ T_C = 25^\circ\text{C}$	Maximum Power Dissipation	100	
$P_D @ T_C = 100^\circ\text{C}$	Maximum Power Dissipation	42	$^\circ\text{C}$
$T_J$	Operating Junction and Storage Temperature Range	-55 to +150	
$T_{STG}$	Soldering Temperature, for 10 sec.	300 (0.063 in. (1.6mm) from case)	
	Mounting Torque, 6-32 or M3 Screw.	10 lbf-in (1.1 N·m)	

### Thermal Resistance

	Parameter	Typ.	Max.	Units
$R_{\theta JC}$	Junction-to-Case - IGBT	—	1.2	$^\circ\text{C}/\text{W}$
$R_{\theta JC}$	Junction-to-Case - Diode	—	2.5	
$R_{\theta CS}$	Case-to-Sink, Flat, Greased Surface	0.24	—	
$R_{\theta JA}$	Junction-to-Ambient, typical socket mount	—	40	
Wt	Weight	6 (0.21)	—	g (oz)

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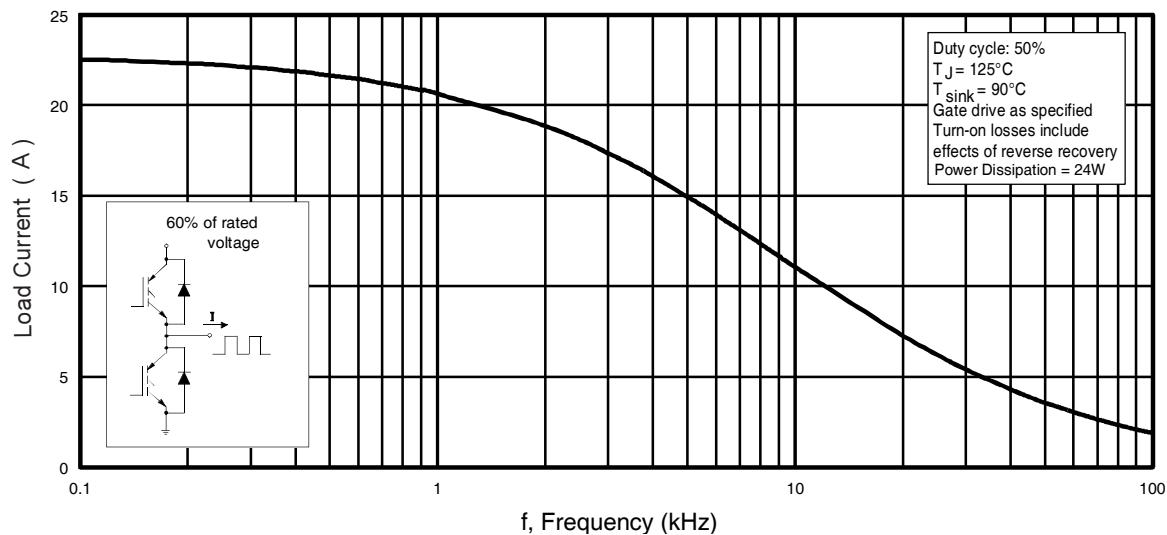
## Electrical Characteristics @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

	Parameter	Min.	Typ.	Max.	Units	Conditions
$V_{(\text{BR})\text{CES}}$	Collector-to-Emitter Breakdown Voltage $\textcircled{3}$	600	—	—	V	$V_{\text{GE}} = 0\text{V}$ , $I_C = 250\mu\text{A}$
$\Delta V_{(\text{BR})\text{CES}/\Delta T_J}$	Temperature Coeff. of Breakdown Voltage	—	0.69	—	$\text{V}/^\circ\text{C}$	$V_{\text{GE}} = 0\text{V}$ , $I_C = 1.0\text{mA}$
$V_{\text{CE}(\text{on})}$	Collector-to-Emitter Saturation Voltage	—	1.59	1.8	V	$I_C = 17\text{A}$ $V_{\text{GE}} = 15\text{V}$
		—	1.99	—		$I_C = 31\text{A}$ See Fig. 2, 5
		—	1.70	—		$I_C = 17\text{A}$ , $T_J = 150^\circ\text{C}$
$V_{\text{GE}(\text{th})}$	Gate Threshold Voltage	3.0	—	6.0		$V_{\text{CE}} = V_{\text{GE}}$ , $I_C = 250\mu\text{A}$
$\Delta V_{\text{GE}(\text{th})/\Delta T_J}$	Temperature Coeff. of Threshold Voltage	—	-11	—	$\text{mV}/^\circ\text{C}$	$V_{\text{CE}} = V_{\text{GE}}$ , $I_C = 250\mu\text{A}$
$g_{\text{fe}}$	Forward Transconductance $\textcircled{4}$	6.1	10	—	S	$V_{\text{CE}} = 100\text{V}$ , $I_C = 17\text{A}$
$I_{\text{CES}}$	Zero Gate Voltage Collector Current	—	—	250	$\mu\text{A}$	$V_{\text{GE}} = 0\text{V}$ , $V_{\text{CE}} = 600\text{V}$
		—	—	2500		$V_{\text{GE}} = 0\text{V}$ , $V_{\text{CE}} = 600\text{V}$ , $T_J = 150^\circ\text{C}$
$V_{\text{FM}}$	Diode Forward Voltage Drop	—	1.4	1.7	V	$I_C = 12\text{A}$ See Fig. 13
		—	1.3	1.6		$I_C = 12\text{A}$ , $T_J = 150^\circ\text{C}$
$I_{\text{GES}}$	Gate-to-Emitter Leakage Current	—	—	$\pm 100$	nA	$V_{\text{GE}} = \pm 20\text{V}$

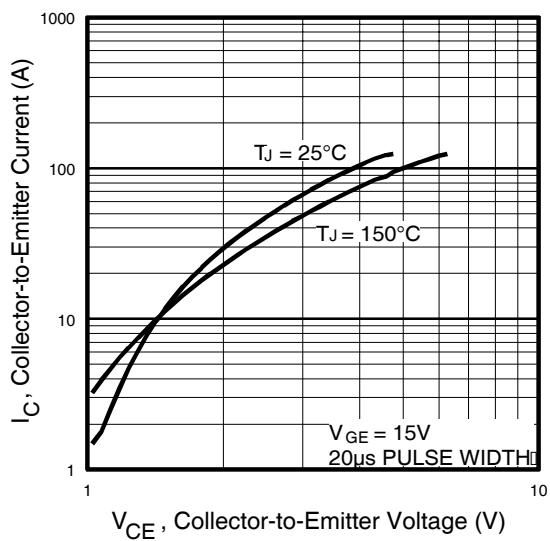
## Switching Characteristics @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

	Parameter	Min.	Typ.	Max.	Units	Conditions
$Q_g$	Total Gate Charge (turn-on)	—	51	77	nC	$I_C = 17\text{A}$
$Q_{\text{ge}}$	Gate - Emitter Charge (turn-on)	—	7.9	12		$V_{\text{CC}} = 400\text{V}$ See Fig. 8
$Q_{\text{gc}}$	Gate - Collector Charge (turn-on)	—	19	28		$V_{\text{GE}} = 15\text{V}$
$t_{d(\text{on})}$	Turn-On Delay Time	—	42	—	ns	$T_J = 25^\circ\text{C}$
$t_r$	Rise Time	—	26	—		$I_C = 17\text{A}$ , $V_{\text{CC}} = 480\text{V}$
$t_{d(\text{off})}$	Turn-Off Delay Time	—	230	350		$V_{\text{GE}} = 15\text{V}$ , $R_G = 23\Omega$
$t_f$	Fall Time	—	160	230	mJ	Energy losses include "tail" and diode reverse recovery. See Fig. 9, 10, 11, 18
$E_{\text{on}}$	Turn-On Switching Loss	—	0.63	—		
$E_{\text{off}}$	Turn-Off Switching Loss	—	1.39	—		
$E_{\text{ts}}$	Total Switching Loss	—	2.02	3.9	mJ	
$t_{d(\text{on})}$	Turn-On Delay Time	—	42	—		$T_J = 150^\circ\text{C}$ , See Fig. 9, 10, 11, 18
$t_r$	Rise Time	—	27	—		$I_C = 17\text{A}$ , $V_{\text{CC}} = 480\text{V}$
$t_{d(\text{off})}$	Turn-Off Delay Time	—	310	—		$V_{\text{GE}} = 15\text{V}$ , $R_G = 23\Omega$
$t_f$	Fall Time	—	310	—	mJ	Energy losses include "tail" and diode reverse recovery.
$E_{\text{ts}}$	Total Switching Loss	—	3.2	—		
$L_E$	Internal Emitter Inductance	—	13	—		Measured 5mm from package
$C_{\text{ies}}$	Input Capacitance	—	1100	—	pF	$V_{\text{GE}} = 0\text{V}$
$C_{\text{oes}}$	Output Capacitance	—	74	—		$V_{\text{CC}} = 30\text{V}$
$C_{\text{res}}$	Reverse Transfer Capacitance	—	14	—		$f = 1.0\text{MHz}$ See Fig. 7
$t_{rr}$	Diode Reverse Recovery Time	—	42	60	ns	$T_J = 25^\circ\text{C}$ See Fig.
		—	80	120		$T_J = 125^\circ\text{C}$ 14
$I_{rr}$	Diode Peak Reverse Recovery Current	—	3.5	6.0	A	$T_J = 25^\circ\text{C}$ See Fig.
		—	5.6	10		$T_J = 125^\circ\text{C}$ 15
$Q_{rr}$	Diode Reverse Recovery Charge	—	80	180	nC	$T_J = 25^\circ\text{C}$ See Fig.
		—	220	600		$T_J = 125^\circ\text{C}$ 16
$dI_{(\text{rec})M}/dt$	Diode Peak Rate of Fall of Recovery During $t_b$	—	180	—	A/ $\mu\text{s}$	$T_J = 25^\circ\text{C}$ See Fig.
		—	120	—		$T_J = 125^\circ\text{C}$ 17

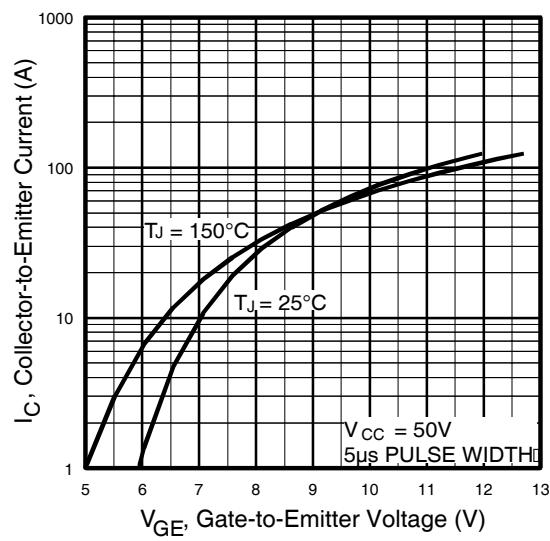
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**Fig. 1 - Typical Load Current vs. Frequency**  
(Load Current =  $I_{RMS}$  of fundamental)

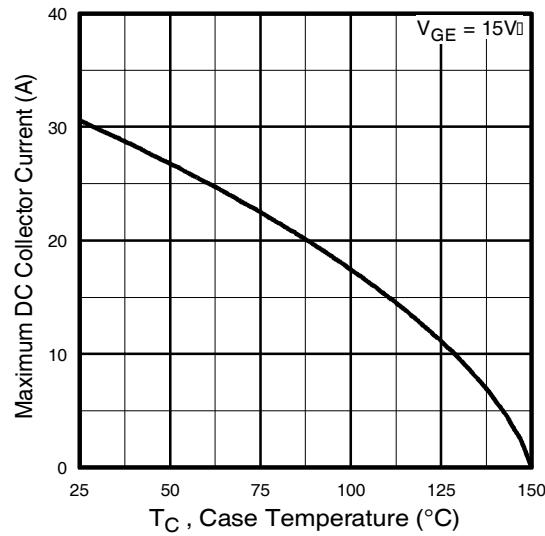


**Fig. 2 - Typical Output Characteristics**

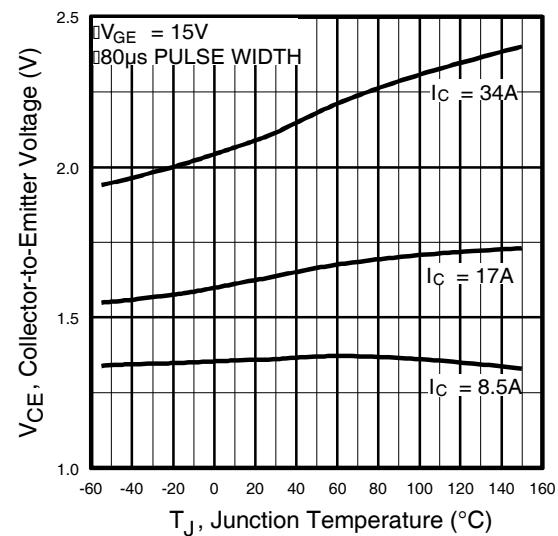


**Fig. 3 - Typical Transfer Characteristics**

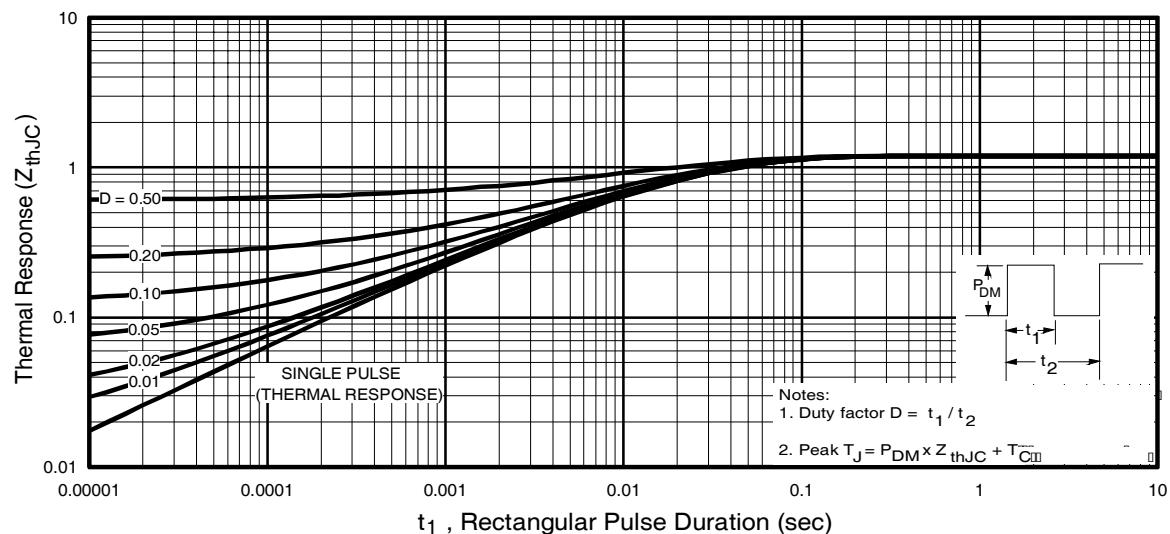
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**Fig. 4 - Maximum Collector Current vs. Case Temperature**

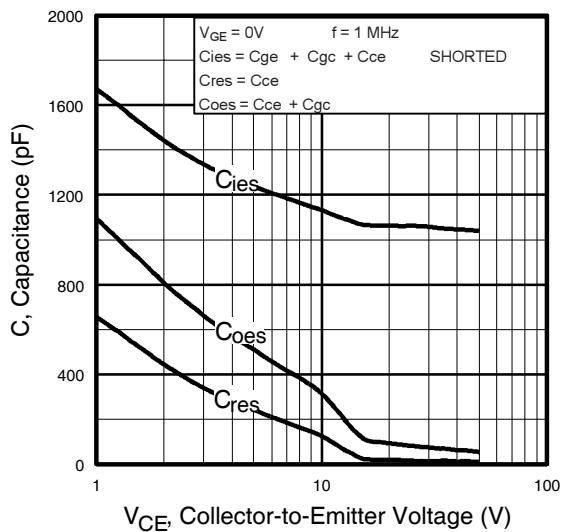


**Fig. 5 - Typical Collector-to-Emitter Voltage vs. Junction Temperature**

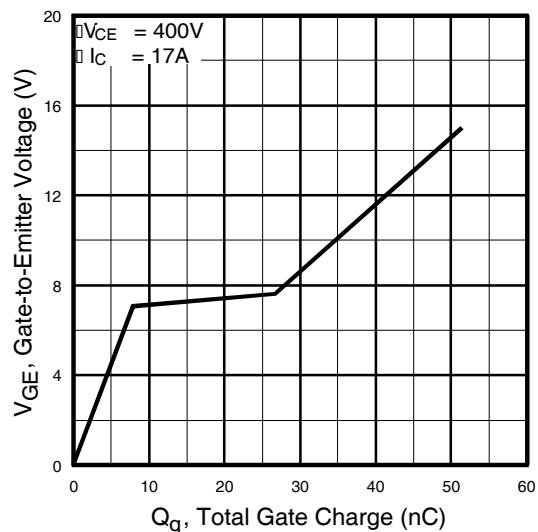


**Fig. 6 - Maximum Effective Transient Thermal Impedance, Junction-to-Case**

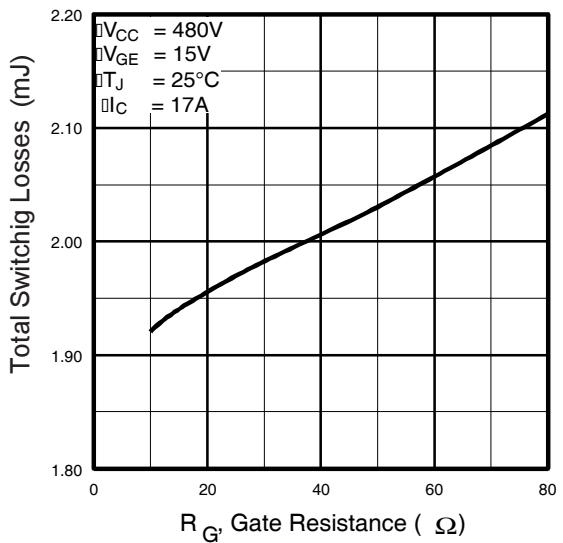
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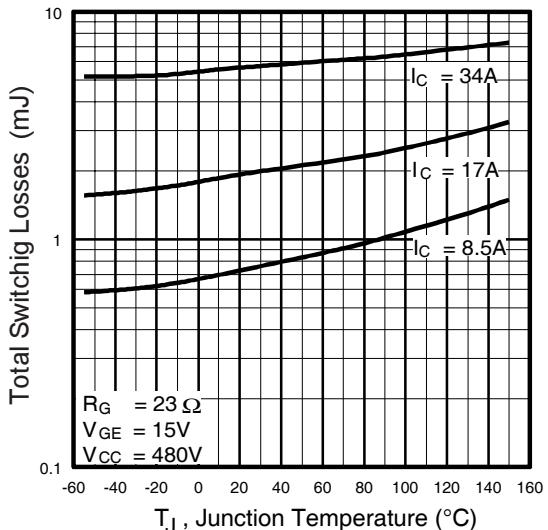
**Fig. 7 - Typical Capacitance vs. Collector-to-Emitter Voltage**



**Fig. 8 - Typical Gate Charge vs. Gate-to-Emitter Voltage**

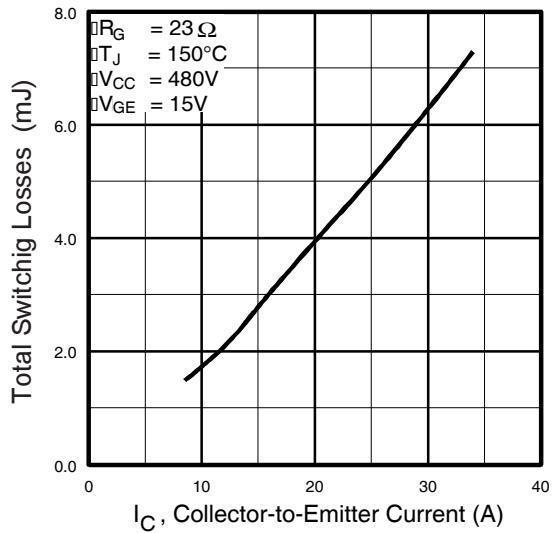


**Fig. 9 - Typical Switching Losses vs. Gate Resistance**

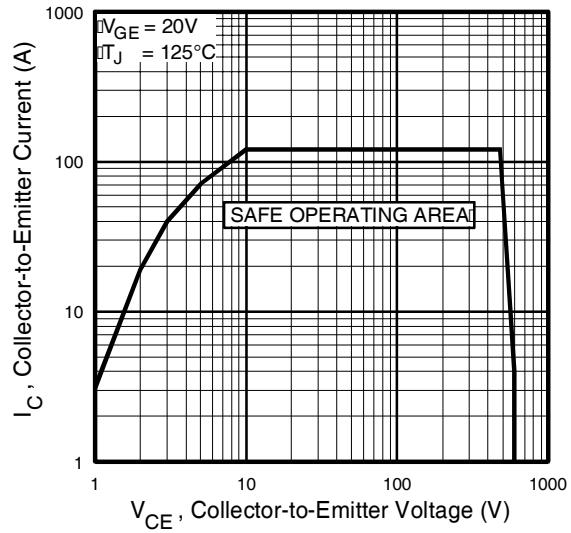


**Fig. 10 - Typical Switching Losses vs. Junction Temperature**

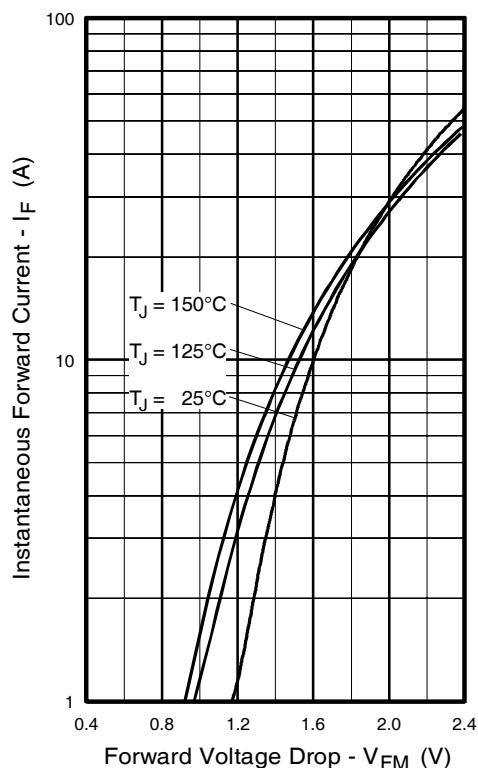
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**Fig. 11 - Typical Switching Losses vs.  
Collector-to-Emitter Current**

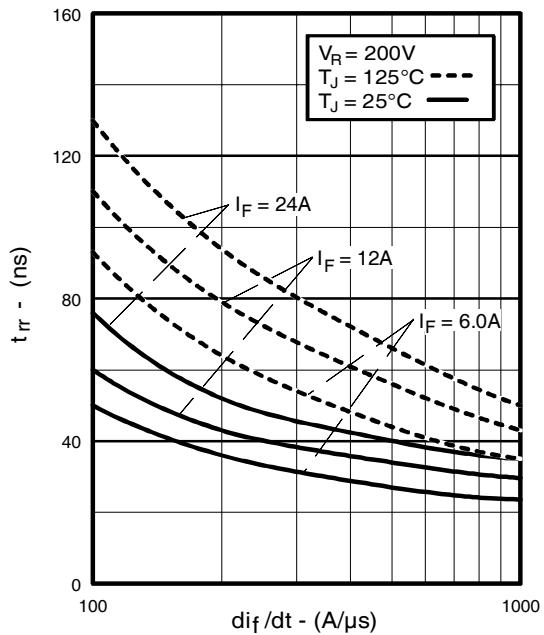


**Fig. 12 - Turn-Off SOA**

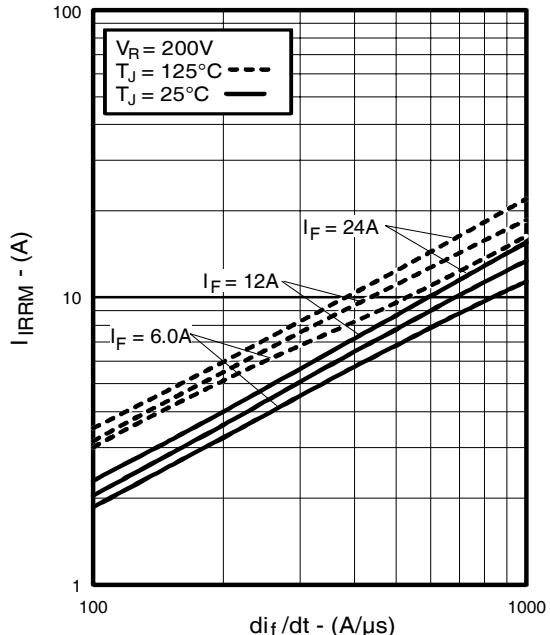


**Fig. 13 - Maximum Forward Voltage Drop vs. Instantaneous Forward Current**

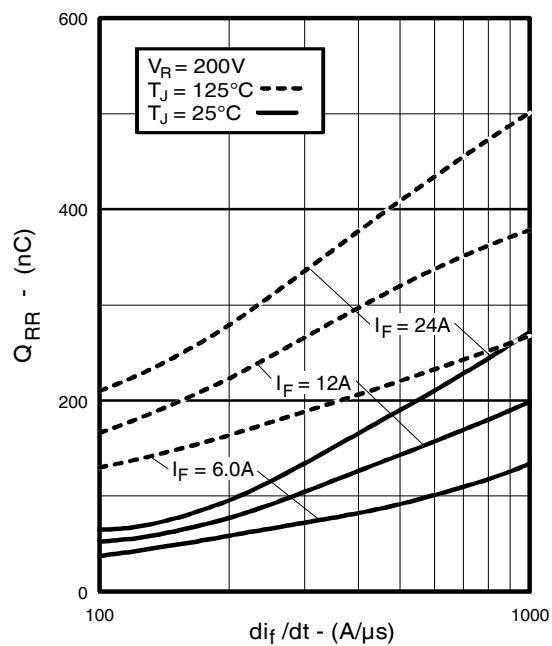
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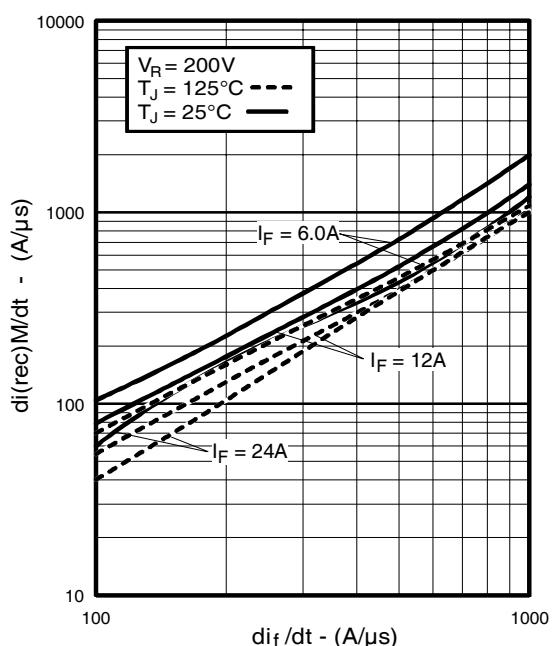
**Fig. 14 - Typical Reverse Recovery vs.  $di_f/dt$**



**Fig. 15 - Typical Recovery Current vs.  $di_f/dt$**

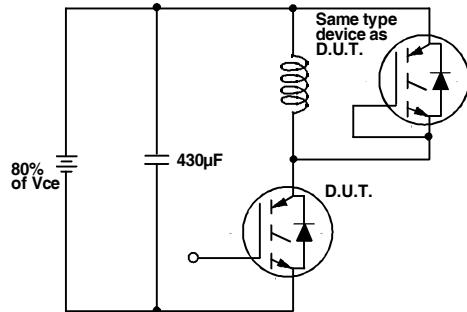


**Fig. 16 - Typical Stored Charge vs.  $di_f/dt$**

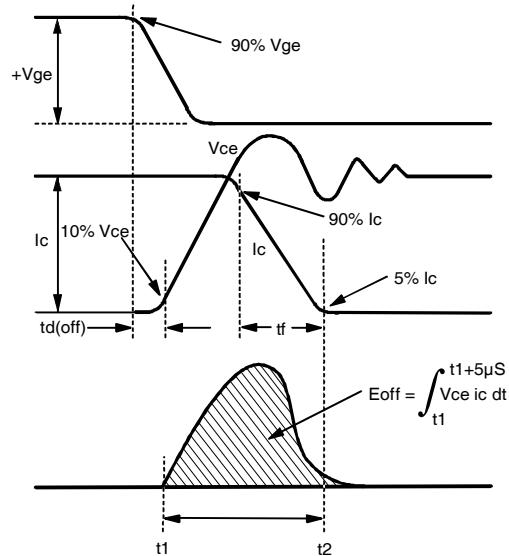


**Fig. 17 - Typical  $di_{(rec)}/dt$  vs.  $di_f/dt$**

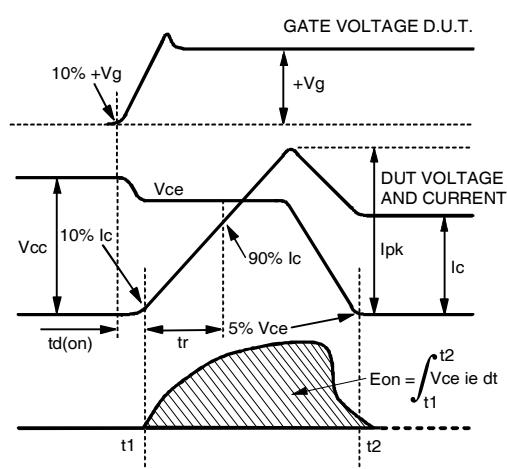
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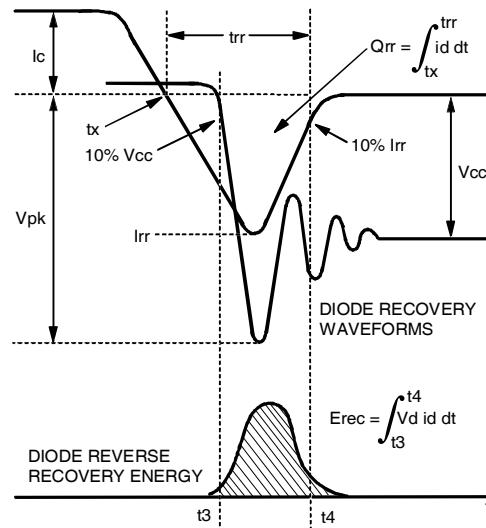
**Fig. 18a** - Test Circuit for Measurement of  $I_{LM}$ ,  $E_{on}$ ,  $E_{off(diode)}$ ,  $t_{rr}$ ,  $Q_{rr}$ ,  $I_{rr}$ ,  $t_d(on)$ ,  $t_r$ ,  $t_d(off)$ ,  $t_f$



**Fig. 18b** - Test Waveforms for Circuit of Fig. 18a, Defining  $E_{off}$ ,  $t_{d(off)}$ ,  $t_f$



**Fig. 18c** - Test Waveforms for Circuit of Fig. 18a, Defining  $E_{on}$ ,  $t_{d(on)}$ ,  $t_r$



**Fig. 18d** - Test Waveforms for Circuit of Fig. 18a, Defining  $E_{rec}$ ,  $t_{rr}$ ,  $Q_{rr}$ ,  $I_{rr}$

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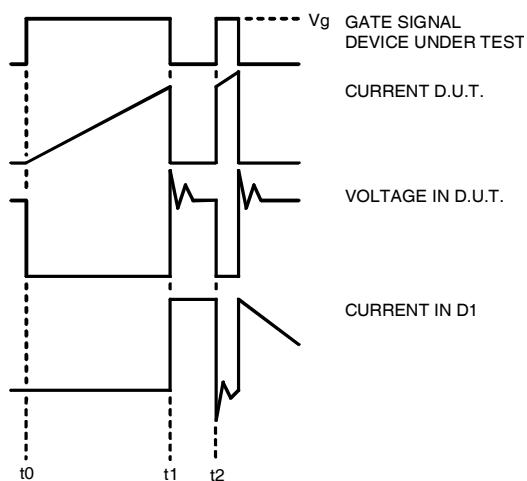


Figure 18e.

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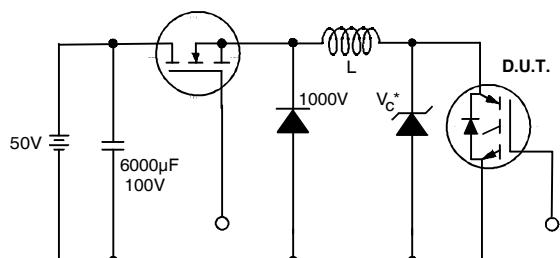


Figure 19.

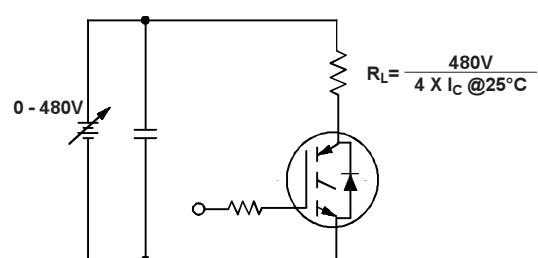


Figure 20.

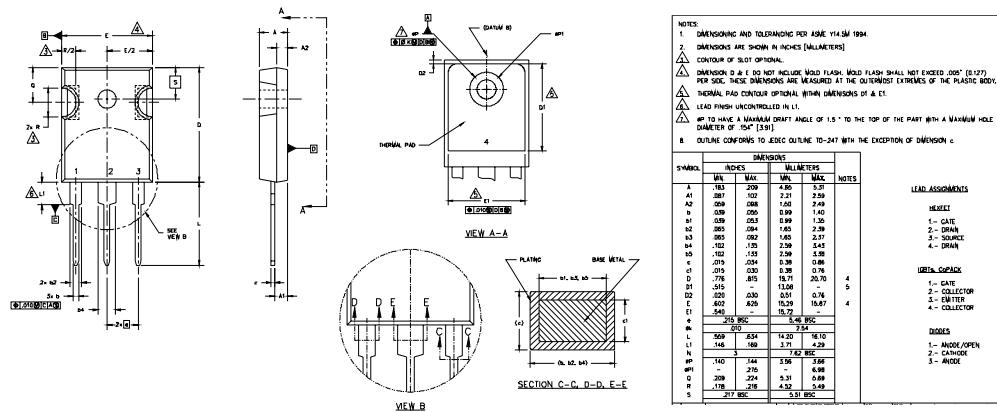
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## Notes:

- ① Repetitive rating:  $V_{GE}=20V$ ; pulse width limited by maximum junction temperature (figure 20)
- ②  $V_{CC}=80\% (V_{CES})$ ,  $V_{GE}=20V$ ,  $L=10\mu H$ ,  $R_G = 23\Omega$  (figure 19)
- ③ Pulse width  $\leq 80\mu s$ ; duty factor  $\leq 0.1\%$ .
- ④ Pulse width  $5.0\mu s$ , single shot.

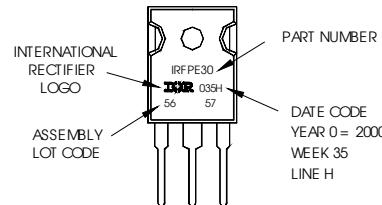
## TO-247AC Package Outline

Dimensions are shown in millimeters (inches)



## TO-247AC Part Marking Information

EXAMPLE: THIS IS AN IRFPE30  
WITH ASSEMBLY  
LOT CODE 5657  
ASSEMBLED ON WW 35, 2000  
IN THE ASSEMBLY LINE "H"  
Note: "P" in assembly line  
position indicates "Lead-Free"



**IR WORLD HEADQUARTERS:** 233 Kansas St., El Segundo, California 90245, USA Tel: (310) 252-7105  
TAC Fax: (310) 252-7903

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*Data and specifications subject to change without notice. 07/04*